

<b>Notice of References Cited</b>	Application/Control No. 10/517,531		Applicant(s)/Patent Under Reexamination SCHULER ET AL.	
	Examiner Thomas Diaz		Art Unit 4171	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-5,333,514	08-1994	Toyama et al.	74/490.06
*	C	US-5,242,336	09-1993	Hori, Kohei	475/336
*	D	US-5,459,925	10-1995	Akeel et al.	29/893.2
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	K	US-			
	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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